

## RF Power Field Effect Transistors

### N-Channel Enhancement-Mode Lateral MOSFETs

Designed for W-CDMA and LTE base station applications with frequencies from 790 to 820 MHz. Can be used in Class AB and Class C for all typical cellular base station modulation formats.

- Typical Single-Carrier W-CDMA Performance:  $V_{DD} = 28$  Volts,  $I_{DQ} = 2000$  mA,  $P_{out} = 96$  Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

Frequency	$G_{ps}$ (dB)	$\eta_D$ (%)	Output PAR (dB)	ACPR (dBc)
790 MHz	20.9	35.2	6.2	-38.1
805 MHz	21.0	35.5	6.2	-38.1
820 MHz	20.9	35.7	6.1	-38.2

- Capable of Handling 10:1 VSWR, @ 32 Vdc, 805 MHz, 500 Watts CW Output Power (3 dB Input Overdrive from Rated  $P_{out}$ ), Designed for Enhanced Ruggedness
- Typical  $P_{out}$  @ 1 dB Compression Point = 340 Watts CW

#### Features

- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source S-Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Designed for Digital Predistortion Error Correction Systems
- Optimized for Doherty Applications
- RoHS Compliant
- In Tape and Reel. R6 Suffix = 150 Units, 56 mm Tape Width, 13 inch Reel. For R5 Tape and Reel option, see p. 14.

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	-0.5, +70	Vdc
Gate-Source Voltage	$V_{GS}$	-6.0, +10	Vdc
Operating Voltage	$V_{DD}$	32, +0	Vdc
Storage Temperature Range	$T_{stg}$	-65 to +150	°C
Case Operating Temperature	$T_C$	150	°C
Operating Junction Temperature (1,2)	$T_J$	225	°C

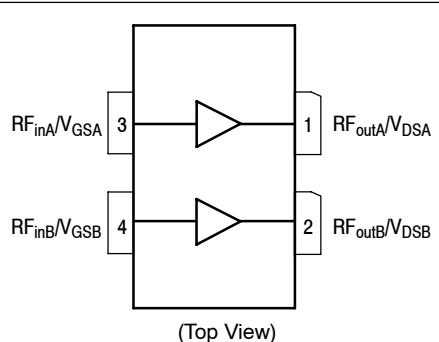
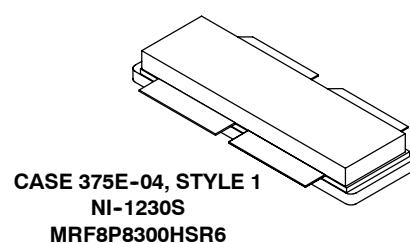
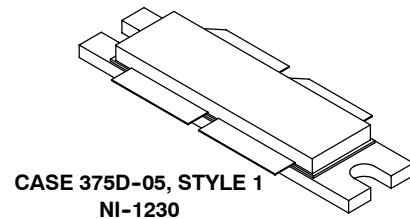
**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 80°C, 96 W CW, 28 Vdc, $I_{DQ} = 2000$ mA, 820 MHz Case Temperature 85°C, 300 W CW, 28 Vdc, $I_{DQ} = 2000$ mA, 820 MHz	$R_{\theta JC}$	0.26 0.21	°C/W

- Continuous use at maximum temperature will affect MTTF.
- MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
- Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

## MRF8P8300HR6 MRF8P8300HSR6

790-820 MHz, 96 W AVG., 28 V  
SINGLE W-CDMA  
LATERAL N-CHANNEL  
RF POWER MOSFETs



**Figure 1. Pin Connections**

**Table 3. ESD Protection Characteristics**

Test Methodology	Class
Human Body Model (per JESD22-A114)	2 (Minimum)
Machine Model (per EIA/JESD22-A115)	A (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>Off Characteristics (1)</b>					
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 70 \text{ Vdc}$ , $V_{GS} = 0 \text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{Adc}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 28 \text{ Vdc}$ , $V_{GS} = 0 \text{ Vdc}$ )	$I_{DSS}$	—	—	1	$\mu\text{Adc}$
Gate-Source Leakage Current ( $V_{GS} = 5 \text{ Vdc}$ , $V_{DS} = 0 \text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{Adc}$
<b>On Characteristics</b>					
Gate Threshold Voltage (1) ( $V_{DS} = 10 \text{ Vdc}$ , $I_D = 400 \mu\text{Adc}$ )	$V_{GS(\text{th})}$	1.5	2.3	3.0	$\text{Vdc}$
Gate Quiescent Voltage ( $V_{DD} = 28 \text{ Vdc}$ , $I_{DQ} = 2000 \text{ mA}$ , Measured in Functional Test)	$V_{GS(Q)}$	2.3	3.1	3.8	$\text{Vdc}$
Drain-Source On-Voltage (1) ( $V_{GS} = 10 \text{ Vdc}$ , $I_D = 3 \text{ Adc}$ )	$V_{DS(\text{on})}$	0.1	0.2	0.3	$\text{Vdc}$

**Functional Tests (2)** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 2000 \text{ mA}$ ,  $P_{out} = 96 \text{ W Avg.}$ ,  $f = 820 \text{ MHz}$ , Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @  $\pm 5 \text{ MHz}$  Offset.

Power Gain	$G_{ps}$	20.0	20.9	23.5	dB
Drain Efficiency	$\eta_D$	34.5	35.7	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	5.9	6.1	—	dB
Adjacent Channel Power Ratio	ACPR	—	-38.2	-36.5	dBc
Input Return Loss	IRL	—	-12	-9	dB

**Typical Broadband Performance** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 2000 \text{ mA}$ ,  $P_{out} = 96 \text{ W Avg.}$ , Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @  $\pm 5 \text{ MHz}$  Offset.

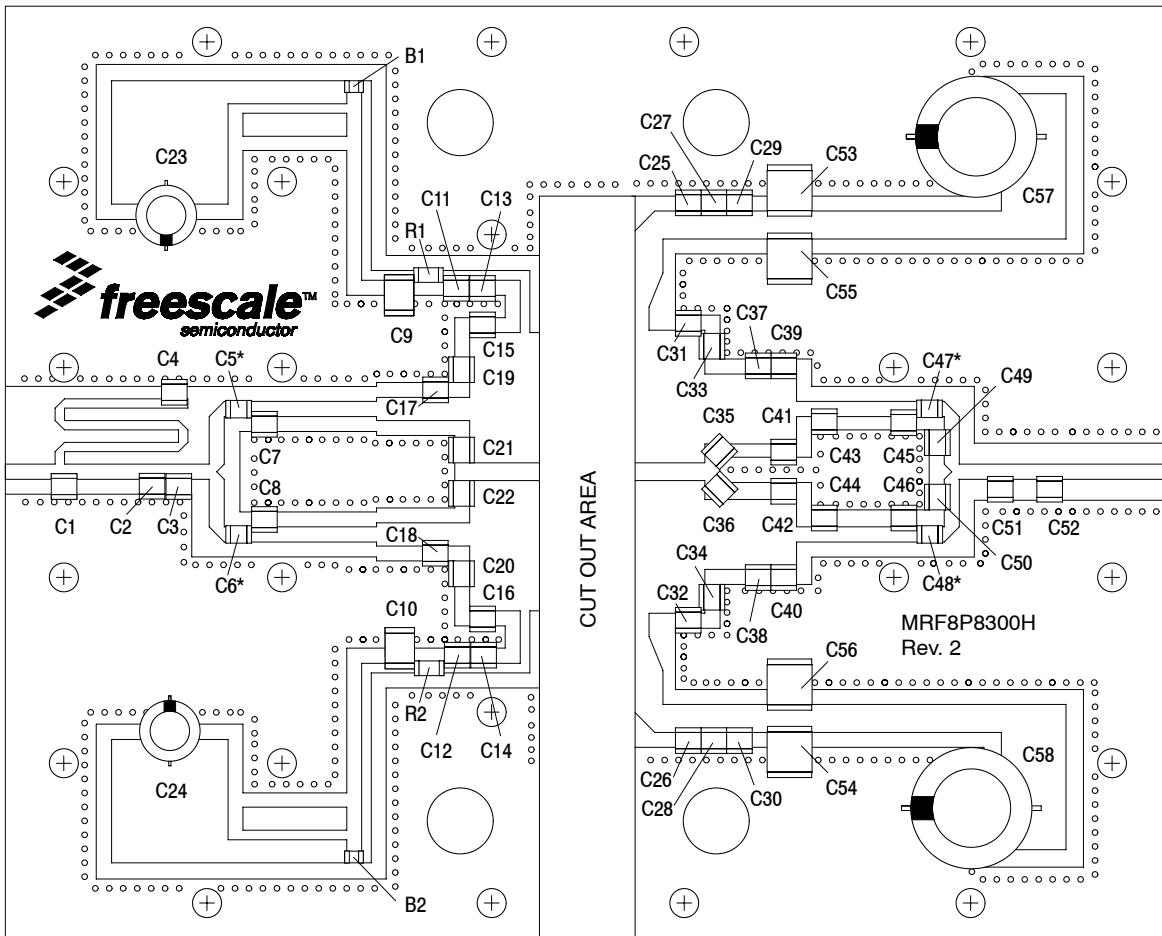
Frequency	$G_{ps}$ (dB)	$\eta_D$ (%)	Output PAR (dB)	ACPR (dBc)	IRL (dB)
790 MHz	20.9	35.2	6.2	-38.1	-11
805 MHz	21.0	35.5	6.2	-38.1	-12
820 MHz	20.9	35.7	6.1	-38.2	-12

1. Each side of device measured separately.
2. Part internally matched both on input and output.

(continued)

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>Typical Performances</b> (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28 \text{ Vdc}$ , $I_{DQ} = 2000 \text{ mA}$ , 790–820 MHz Bandwidth					
$P_{out}$ @ 1 dB Compression Point, CW	$P_{1\text{dB}}$	—	340	—	W
IMD Symmetry @ 290 W PEP, $P_{out}$ where IMD Third Order Intermodulation $\leq 30 \text{ dBc}$ (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands $> 2 \text{ dB}$ )	$\text{IMD}_{\text{sym}}$	—	35	—	MHz
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	$\text{VBW}_{\text{res}}$	—	35	—	MHz
Gain Flatness in 30 MHz Bandwidth @ $P_{out} = 96 \text{ W Avg.}$	$G_F$	—	0.5	—	dB
Gain Variation over Temperature ( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )	$\Delta G$	—	0.0185	—	dB/ $^\circ\text{C}$
Output Power Variation over Temperature ( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )	$\Delta P_{1\text{dB}}$	—	0.0076	—	dB/ $^\circ\text{C}$



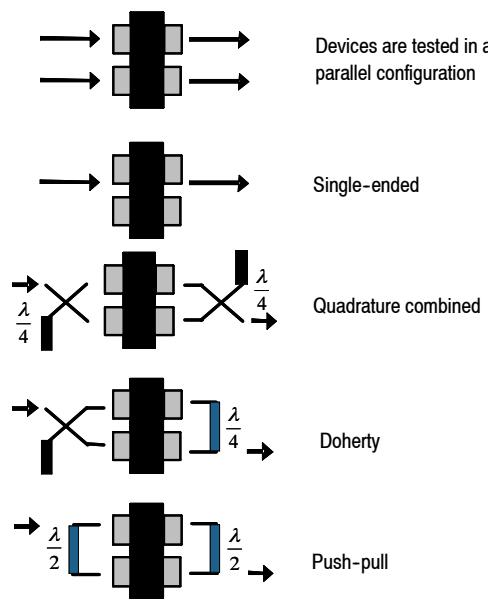
\*C5, C6, C47, and C48 are mounted vertically.

**Figure 2. MRF8P8300HR6(HSR6) Test Circuit Component Layout**

**Table 5. MRF8P8300HR6(HSR6) Test Circuit Component Designations and Values**

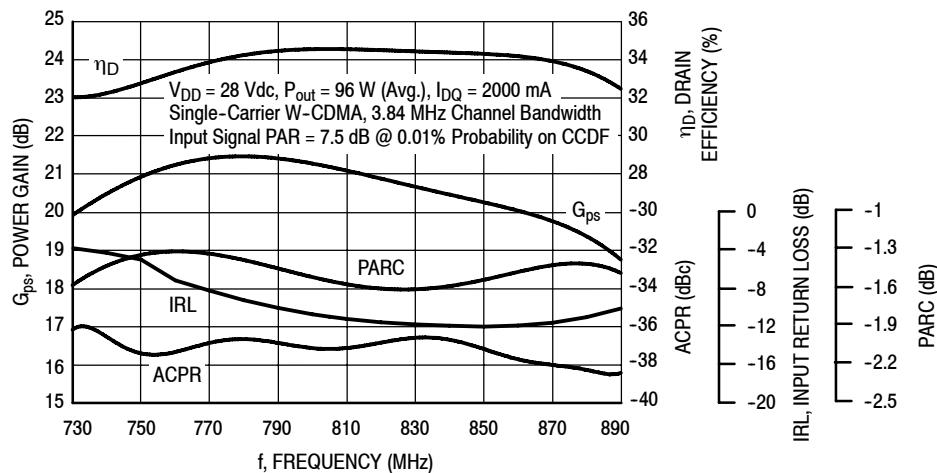
Part	Description	Part Number	Manufacturer
B1, B2	Short Ferrite Beads	MPZ2012S300AT000	TDK
C1, C2, C39, C40, C41, C42	2.1 pF Chip Capacitors	ATC100B2R1BT500XT	ATC
C3, C49, C50	1.0 pF Chip Capacitors	ATC100B1R0BT500XT	ATC
C4	120 pF Chip Capacitor	ATC100B121JT500XT	ATC
C5, C6, C11, C12, C47, C48	39 pF Chip Capacitors	ATC100B390JT500XT	ATC
C7, C8, C45, C46	1.1 pF Chip Capacitors	ATC100B1R1BT500XT	ATC
C9, C10	4.7 $\mu$ F, 50 V Chip Capacitors	C4532X5R1H475KT	TDK
C13, C14, C19, C20, C25, C26	10 pF Chip Capacitors	ATC100B100JT500XT	ATC
C15, C16, C35, C36	4.7 pF Chip Capacitors	ATC100B4R7CT500XT	ATC
C17, C18	4.3 pF Chip Capacitors	ATC100B4R3CT500XT	ATC
C21, C22	8.2 pF Chip Capacitors	ATC100B8R2CT500XT	ATC
C23, C24	22 $\mu$ F Electrolytic Capacitors	UD1V220MCL1GS	Nichicon
C27, C28	20 pF Chip Capacitors	ATC100B200JT500XT	ATC
C29, C30	30 pF Chip Capacitors	ATC100B300JT500XT	ATC
C31, C32	13 pF Chip Capacitors	ATC100B130JT500XT	ATC
C33, C34	7.5 pF Chip Capacitors	ATC100B7R5CT500XT	ATC
C37, C38	1.5 pF Chip Capacitors	ATC100B1R5BT500XT	ATC
C43, C44	0.8 pF Chip Capacitors	ATC100B0R8BT500XT	ATC
C51, C52	2.0 pF Chip Capacitors	ATC100B2R0BT500XT	ATC
C53, C54, C55, C56	22 $\mu$ F, 50 V Chip Capacitors	C5750JF1H226ZT	TDK
C57, C58	470 $\mu$ F, 63 V Electrolytic Capacitors	MCGPR63V477M13X26-RH	Multicomp
R1, R2	3 $\Omega$ Chip Resistors	CRCW12063R00FNEA	Vishay
PCB	0.030", $\epsilon_r = 3.5$	RF35A2	Taconic

#### MRF8P8300HR6 MRF8P8300HSR6

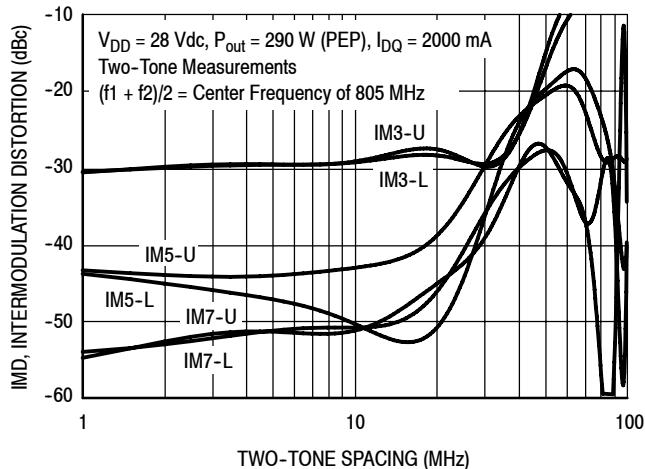


**Figure 3. Possible Circuit Topologies**

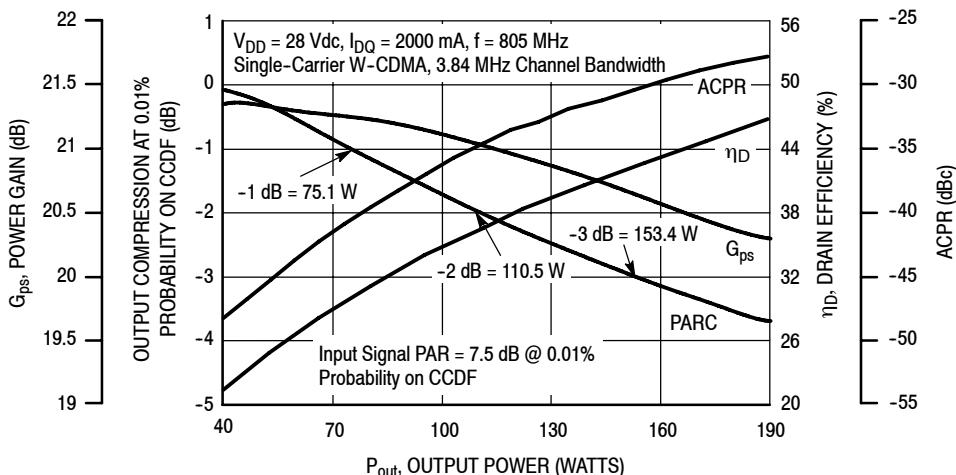
## TYPICAL CHARACTERISTICS



**Figure 4. Output Peak-to-Average Ratio Compression (PARC)  
Broadband Performance @  $P_{out}$  = 96 Watts Avg.**

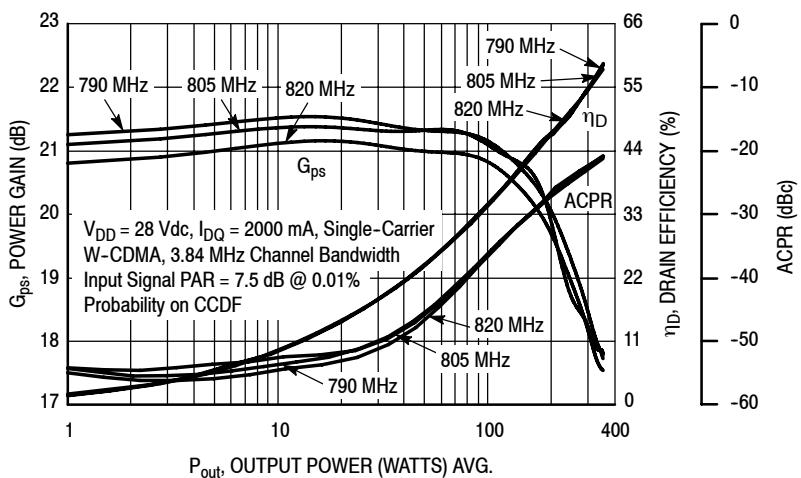


**Figure 5. Intermodulation Distortion Products  
versus Two-Tone Spacing**

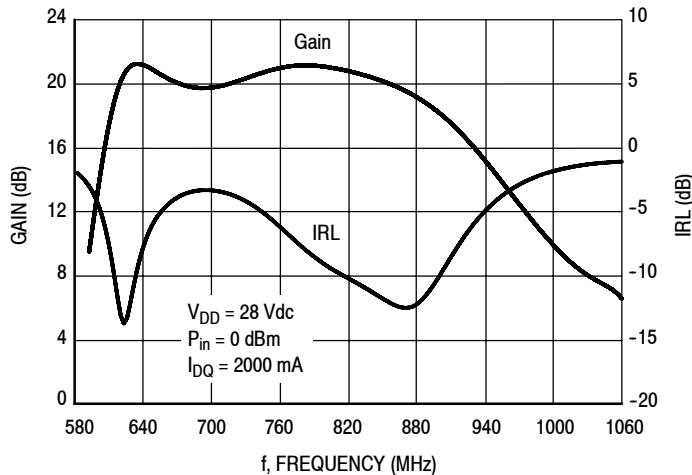


**Figure 6. Output Peak-to-Average Ratio  
Compression (PARC) versus Output Power**

## TYPICAL CHARACTERISTICS

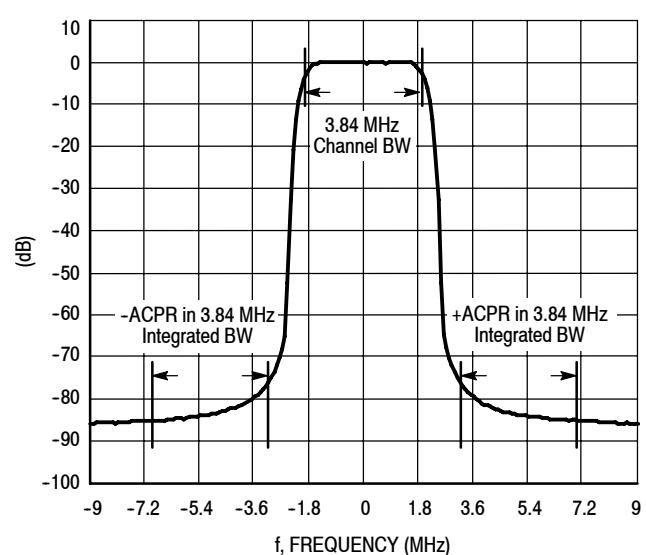
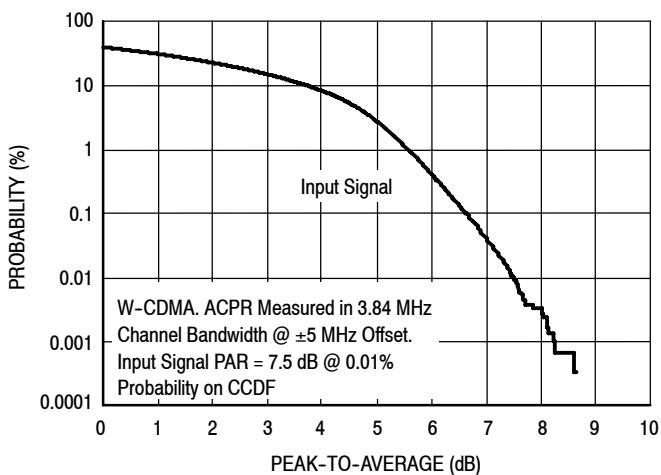


**Figure 7. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power**



**Figure 8. Broadband Frequency Response**

## W-CDMA TEST SIGNAL



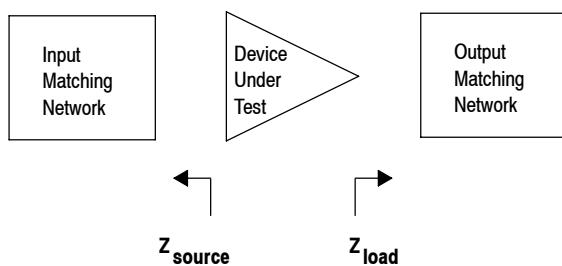
**MRF8P8300HR6 MRF8P8300HSR6**

$V_{DD} = 28$  Vdc,  $I_{DQ} = 2000$  mA,  $P_{out} = 96$  W Avg.

f MHz	$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
730	1.07 - j1.15	0.86 - j0.18
750	1.06 - j0.97	0.90 + j0.04
770	1.11 - j0.78	1.07 + j0.46
790	1.05 - j0.62	1.28 - j0.67
810	1.11 - j0.45	0.88 - j0.12
830	1.19 - j0.26	0.87 + j0.04
850	1.95 + j0.48	0.82 + j0.05
870	1.35 - j1.66	0.71 + j0.12
890	0.95 - j1.07	0.59 + j0.22

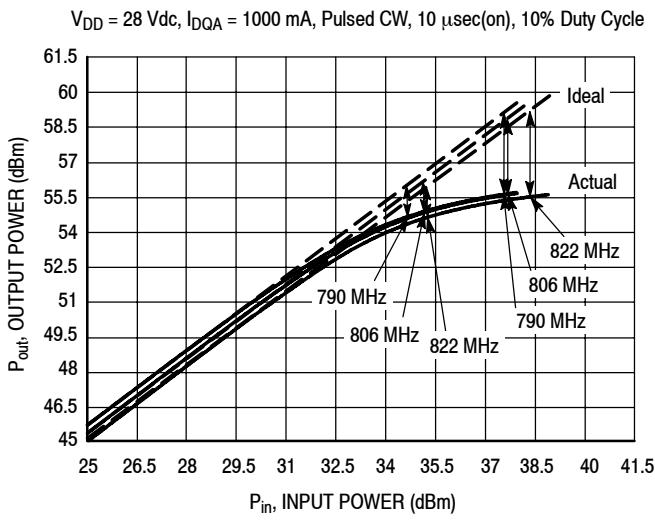
$Z_{source}$  = Test circuit impedance as measured from gate to ground, gate leads are tied together.

$Z_{load}$  = Test circuit impedance as measured from drain to ground, drain leads are tied together.



**Figure 11. Series Equivalent Source and Load Impedance**

## ALTERNATIVE PEAK TUNE LOAD PULL CHARACTERISTICS



NOTE: Load Pull Test Fixture Tuned for Peak P1dB Output Power @ 28 V

$f$ (MHz)	P1dB		P3dB	
	Watts	dBm	Watts	dBm
790	288	54.6	363	55.6
806	299	54.8	366	55.6
822	287	54.6	349	55.4

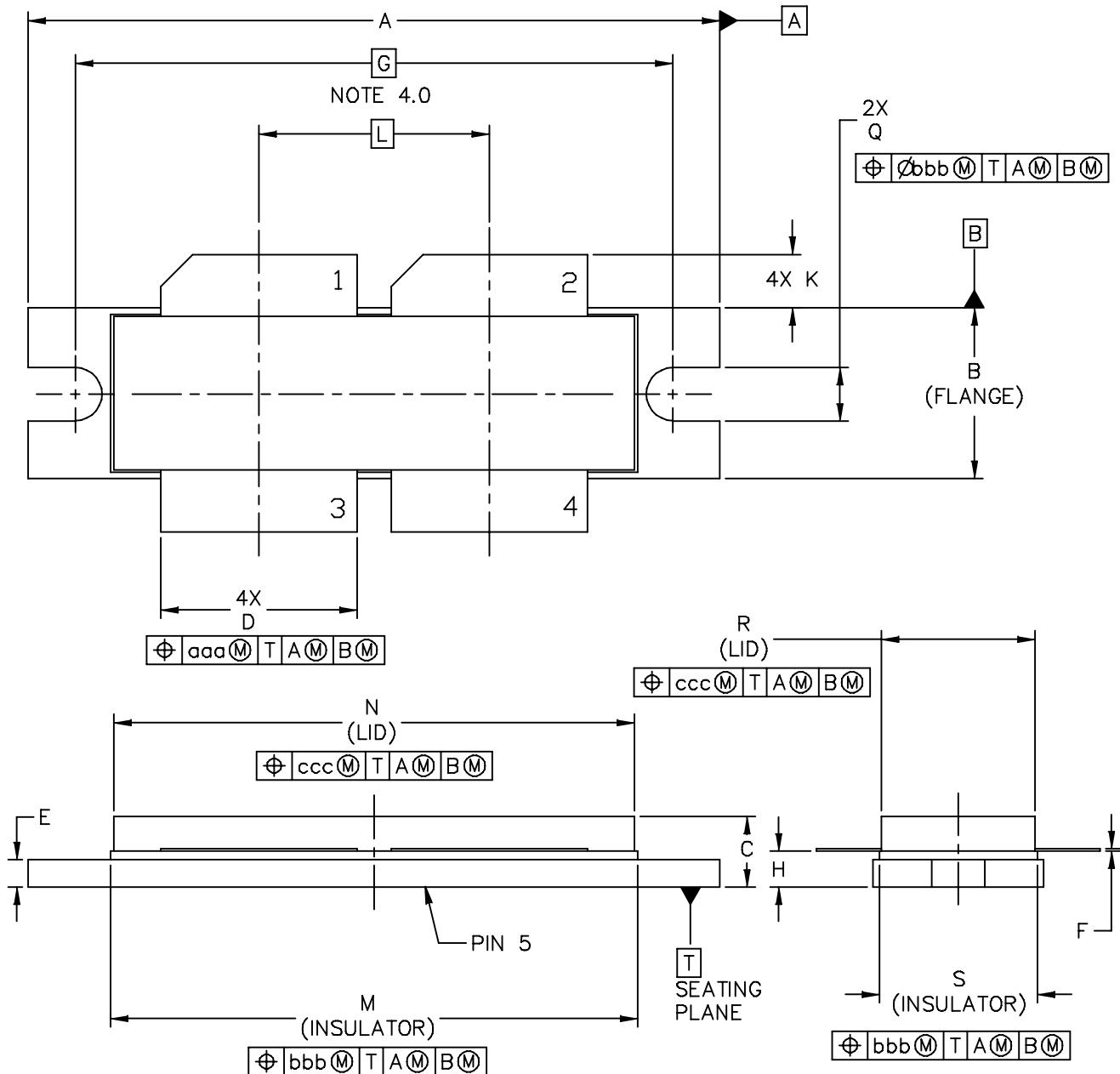
Test Impedances per Compression Level

$f$ (MHz)		$Z_{source}$ $\Omega$	$Z_{load}$ $\Omega$
790	P1dB	1.04 - j0.98	0.78 - j0.73
806	P1dB	1.16 - j1.39	0.76 - j0.71
822	P1dB	1.24 - j1.73	0.76 - j0.74

**Figure 12. Pulsed CW Output Power  
versus Input Power @ 28 V**

NOTE: Measurement made on a per side basis.

## PACKAGE DIMENSIONS



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TITLE:  NI-1230	DOCUMENT NO: 98ASB16977C  CASE NUMBER: 375D-05  STANDARD: NON-JEDEC	REV: E  31 MAR 2005

**MRF8P8300HR6 MRF8P8300HSR6**

RF Device Data  
Freescale Semiconductor

NOTES:

1. 0 INTERPRET DIMENSIONS AND TOLERANCES  
PER ASME Y14.5M-1994.

2. 0 CONTROLLING DIMENSION: INCH

3. 0 DIMENSION H IS MEASURED .030 (.762)  
AWAY FROM PACKAGE BODY.

4. 0 RECOMMENDED BOLT CENTER DIMENSION OF  
1.52 (38.61) BASED ON M3 SCREW.

STYLE 1:

PIN 1 - DRAIN  
2 - DRAIN  
3 - GATE  
4 - GATE  
5 - SOURCE

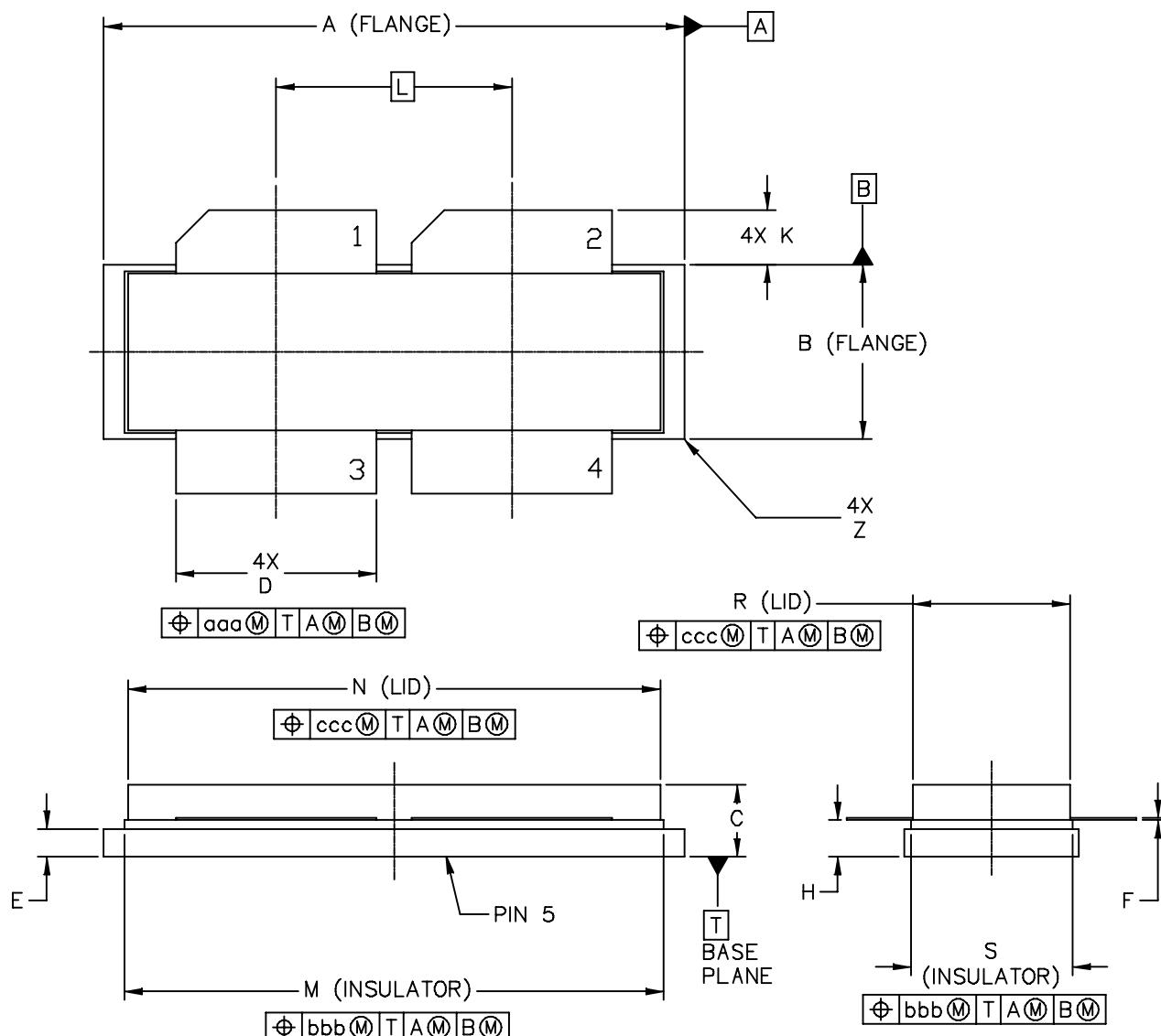
DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	1.615	1.625	41.02	41.28	N	1.218	1.242	30.94	31.55
B	.395	.405	10.03	10.29	Q	.120	.130	3.05	3.3
C	.150	.200	3.81	5.08	R	.355	.365	9.01	9.27
D	.455	.465	11.56	11.81	S	.365	.375	9.27	9.53
E	.062	.066	1.57	1.68					
F	.004	.007	0.1	0.18					
G	1.400 BSC		35.56 BSC		aaa		.013		0.33
H	.082	.090	2.08	2.29	bbb		.010		0.25
K	.117	.137	2.97	3.48	ccc		.020		0.51
L	.540 BSC		13.72 BSC						
M	1.219	1.241	30.96	31.52					

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**MECHANICAL OUTLINE**

**PRINT VERSION NOT TO SCALE**

TITLE:  NI-1230	DOCUMENT NO: 98ASB16977C	REV: E
	CASE NUMBER: 375D-05	31 MAR 2005
	STANDARD: NON-JEDEC	



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NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH
3. DIMENSION H IS MEASURED .030 AWAY FROM PACKAGE BODY

STYLE 1:

PIN 1	- DRAIN
2	- DRAIN
3	- GATE
4	- GATE
5	- SOURCE

DIM	INCHES		MILLIMETERS		DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
A	1.265	1.275	32.13	32.38	R	.355	.365	9.01	9.27
B	.395	.405	10.03	10.29	S	.365	.375	9.27	9.53
C	.150	.200	3.81	5.08	Z	---	.040	---	1.02
D	.455	.465	11.56	11.81					
E	.062	.066	1.57	1.68	aaa		.013		0.33
F	.004	.007	0.1	0.18	bbb		.010		0.25
H	.082	.090	2.08	2.29	ccc		.020		0.51
K	.117	.137	2.97	3.48					
L	.540 BSC		13.72 BSC						
M	1.219	1.241	30.96	31.52					
N	1.218	1.242	30.94	31.55					

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## PRODUCT DOCUMENTATION, TOOLS AND SOFTWARE

Refer to the following documents, tools and software to aid your design process.

### Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software and Tools, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

## R5 TAPE AND REEL OPTION

R5 Suffix = 50 Units, 56 mm Tape Width, 13 inch Reel.

The R5 tape and reel option for MRF8P8300H and MRF8P8300HS parts will be available for 2 years after release of MRF8P8300H and MRF8P8300HS. Freescale Semiconductor, Inc. reserves the right to limit the quantities that will be delivered in the R5 tape and reel option. At the end of the 2 year period customers who have purchased these devices in the R5 tape and reel option will be offered MRF8P8300H and MRF8P8300HS in the R6 tape and reel option.

## REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Jan. 2011	• Initial Release of Data Sheet

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